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## DESCRIPTION

SEMICONDUCTOR INTEGRATED CIRCUIT AND  
NONCONTACT INFORMATION SYSTEM INCLUDING IT

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RELATED APPLICATIONS

This application is the U.S. National Phase under 35 U.S.C. § 371 of International Application No. PCT/JP2005/007073, filed on April 12, 2005, which in turn claims the benefit of Japanese Application No. 2004-120168, filed on April 15, 2004, the disclosures of which Applications are incorporated by reference herein.

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## TECHNICAL FIELD

[0001] The present invention relates to a semiconductor integrated circuit to which power is supplied via electromagnetic waves, and an information system (contactless type information system) including a contactless type information medium including such a semiconductor integrated circuit.

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## BACKGROUND ART

[0002] Recently, data carriers such as contactless IC cards, which are capable of transmitting and receiving data while receiving power supply at the same time by using a semiconductor integrated circuit to which power is supplied via electromagnetic waves of a predetermined wavelength utilizing the mutual induction between coils, have reached the stage of practical application. Contactless IC cards are classified into the close-coupled type, the proximity type and the vicinity type based on the reading range between the contactless IC card and the reader/writer, which is a device for exchanging radio waves

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with the contactless IC card. The standard specification for each type is being fully prepared.

[0003] Particularly, proximity type contactless IC cards, which can be used over a distance of up to about 10 [cm] from the reader/writer, are often used in applications such as train passes, with which the ticket gate can be opened and closed based on the contactless exchange of information with the reader/writer, wherein the users do not need to take their train passes (contactless IC cards) out of the train pass holders at the ticket gate, or the like. Thus, contactless IC cards and information systems (contactless type information systems) using the same can potentially be used in a very wide variety of applications.

[0004] When data is returned from a contactless IC card to a reader/writer, for example, in such a contactless type information system, the load of a magnetically-coupled coil (antenna coil) of the contactless IC card is varied to modulate the signal (data), thus realizing the return of data.

[0005] In a contactless type information system, if the voltage caused by the mutual induction between coils drops when exchanging data due to, for example, the physical distance between the contactless IC card and the reader/writer being excessive, it may disable communications between the contactless IC card and the reader/writer. Therefore, conventional contactless IC cards ensure accurate data communications by resetting the internal semiconductor integrated circuit when the power supply voltage becomes lower than a predetermined reset detection lower limit voltage. (See, for example, Patent Document 1.)

Patent Document 1: Japanese Laid-Open Patent Publication No. 8-77318

## DISCLOSURE OF THE INVENTION

### Problems To Be Solved By The Invention

[0006] However, where the signal is modulated by varying the load of the antenna coil, the voltage through the antenna coil temporarily drops during the period in which data is being returned from the contactless IC card to the reader/writer, even if the physical distance between the contactless IC card and the reader/writer is not excessive.

5 [0007] Thus, with a conventional contactless IC card, when the physical distance between the contactless IC card and the reader/writer exceeds a certain distance or when data is returned to the reader/writer, thereby lowering the voltage through the antenna coil so that the power supply voltage is lower than the reset detection lower limit voltage, the semiconductor integrated circuit in the contactless IC card may constantly be reset even in  
10 the middle of a data exchange, thus failing to exchange data between the contactless IC card and the reader/writer.

[0008] In view of the problem, an object of the present invention is to provide a contactless type information medium with which it is possible to extend the reading range between the contactless type information medium (semiconductor integrated circuit) and a  
15 reader/writer, which exchanges data in contactless communications with the contactless type information medium, and to enable a stable data exchange even if the power supply voltage is lowered when data is returned from the contactless type information medium to the reader/writer.

#### Means For Solving The Problems

20 [0009] In order to achieve the object, the present invention ~~of claim 1 is~~ relates to a semiconductor integrated circuit, to which a power supply voltage is supplied via electromagnetic waves received by an antenna coil, and which exchanges data via the antenna coil, the semiconductor integrated circuit comprising:

- a memory circuit storing data;
- 25 a pair of terminals to which the antenna coil is connected;
- a modulating-transmitting circuit for transmitting data via the antenna coil by

varying a load between the terminals according to data to be transmitted;

a transmission control circuit for outputting data stored in the memory circuit to the modulating-transmitting circuit; and

a reset signal generating circuit for outputting a reset signal for resetting the transmission control circuit to the transmission control circuit when the power supply voltage decreases below a predetermined threshold value, wherein:

the transmission control circuit is configured to output a transmission status signal, which indicates that data is being transmitted; and

the reset signal generating circuit is configured so that the threshold value is lower during a period in which the transmission status signal is being output than during a period in which the transmission status signal is not being output.

[0010] Thus, the power supply voltage (reset detection lower limit voltage) for which the reset signal is output is changed based on whether data is being transmitted. Therefore, by connecting the semiconductor integrated circuit to a coil (antenna coil) transmitting/receiving electromagnetic waves of a predetermined frequency to/from a contactless type information medium (contactless IC card), it is possible to extend the reading range between the contactless IC card and a reader/writer, which supplies the power supply voltage to, and exchange data with, the contactless IC card via electromagnetic waves, and to enable a stable data exchange.

[0011] The present invention ~~of claim 2 is the~~ also relates to a semiconductor integrated circuit ~~of claim 1~~, wherein the reset signal generating circuit includes a voltage-dividing resistor for dividing the power supply voltage and is configured so as to output the reset signal when a voltage obtained by the voltage division by the voltage-dividing resistor is lower than a predetermined reference voltage.

[0012] The present invention ~~of claim 3 is the~~ also relates to a semiconductor integrated circuit ~~of claim 2~~, wherein the reset signal generating circuit is configured to

change a voltage division ratio so that the voltage obtained by the voltage division is higher during a period in which the transmission status signal is being output than during a period in which the transmission status signal is not being output.

[0013] The present invention ~~of claim 4 is the~~ also relates to a semiconductor integrated circuit ~~of claim 3~~, wherein:

the voltage-dividing resistor is a series of resistors including three or more resistors; and

the reset signal generating circuit is configured to change the voltage division ratio by changing the number of transistors of the series of resistors for dividing the power supply voltage.

[0014] Thus, it is possible to change the number of resistors of the voltage-dividing resistor to thereby switch the reset detection lower limit voltage from one to another with a simple circuit configuration without increasing the circuit scale.

[0015] The present invention ~~of claim 5 is the~~ also relates to a semiconductor integrated circuit ~~of any one of claims 1 to 4~~, wherein the transmission control circuit is configured to output the transmission status signal while simultaneously outputting data stored in the memory circuit to the modulating-transmitting circuit.

[0016] Thus, before the power supply voltage decreases below the reset detection lower limit voltage, the reset detection lower limit voltage can be switched to be low.

[0017] The present invention ~~of claim 6 is the~~ also relates to a semiconductor integrated circuit ~~of claim 1~~, wherein the transmission control circuit includes a buffer for holding data stored in the memory circuit and is configured to output data held in the buffer to the modulating-transmitting circuit.

[0018] Thus, data to be transmitted is held in the transmission control circuit, whereby the memory circuit is not activated when the data is transmitted. Specifically, a transmission control circuit, which typically includes only logic gates, is capable of

operating at a lower voltage than a memory circuit, which includes not only logic gates but also memory cells, etc. Therefore, even if the reset detection lower limit voltage is lowered during a period in which data is being transmitted, it is possible to extend the reading range between the contactless IC card and the reader/writer and to enable a stable data exchange.

[0019] The present invention ~~of claim 7 is the~~ also relates to a semiconductor integrated circuit ~~of claim 1~~, wherein the transmission control circuit is configured to stop outputting the transmission status signal after an amount of time greater than or equal to an amount of time required for outputting data to the modulating-transmitting circuit has elapsed since completion of the data output to the modulating-transmitting circuit.

[0020] Thus, it is possible to prevent a reset signal from being output inadvertently, when the power supply voltage rises late due to the internal capacitance of the semiconductor integrated circuit being large, after the data transmission is completed.

[0021] The present invention ~~of claim 8 is the~~ also relates to a semiconductor integrated circuit ~~of claim 1~~, further comprising a high-voltage side reset signal generating circuit for outputting, to the transmission control circuit, a reset signal for resetting the transmission control circuit when the power supply voltage exceeds a predetermined threshold value,

wherein the high-voltage side reset signal generating circuit is configured so that the threshold value is lower during a period in which the transmission status signal is being output than during a period in which the transmission status signal is not being output.

[0022] The present invention ~~of claim 9 is the~~ also relates to a semiconductor integrated circuit ~~of claim 8~~, wherein the high-voltage side reset signal generating circuit includes a voltage-dividing resistor for dividing the power supply voltage and is configured to output the reset signal when a voltage obtained by the voltage division by the

voltage-dividing resistor is higher than a predetermined reference voltage.

[0023] The present invention ~~of claim 10 is the~~ also relates to a semiconductor integrated circuit ~~of claim 9~~, wherein the high-voltage side reset signal generating circuit is configured to change a voltage division ratio so that the voltage obtained by the voltage division during a period in which the transmission status signal is being output is higher than that during a period in which the transmission status signal is not being output.

[0024] The present invention ~~of claim 11 is the~~ also relates to a semiconductor integrated circuit ~~of claim 10~~:

the voltage-dividing resistor is a series of resistors including three or more resistors; and

the high-voltage side reset signal generating circuit is configured to change the voltage division ratio by changing the number of transistors of the series of resistors for dividing the power supply voltage.

[0025] Thus, the reset signal is output when the power supply voltage becomes higher than a predetermined voltage (reset detection upper limit voltage), and the reset detection upper limit voltage is switched from one to another based on whether data is being transmitted. Therefore, if one attempts to externally supply a power supply voltage to operate the semiconductor integrated circuit, without using predetermined electromagnetic waves, the input voltage needs to always be higher than the reset detection lower limit voltage and lower than the reset detection upper limit voltage so that the reset signal RESET will not be generated. Thus, it is very difficult to operate the semiconductor integrated circuit by externally supplying a power supply voltage. This substantially improves the security of the contactless IC card.

[0026] The present invention ~~of claim 12 is~~ also relates to a contactless type information system, comprising:

a contactless type information medium including the semiconductor integrated

circuit of ~~claim 1~~ noted above and an antenna coil connected to the semiconductor integrated circuit for transmitting/receiving electromagnetic waves; and

a data transmitting/receiving device for supplying a power supply voltage to, and exchanging data with, the contactless type information medium via electromagnetic waves.

[0027] Thus, it is possible to extend the reading range between a contactless type information medium (contactless IC card) and a data transmitting/receiving device (reader/writer), which supplies the power supply voltage to, and exchange data with, the contactless IC card, and to enable a stable data exchange.

#### Effects Of The Invention

[0028] According to the present invention, it is possible to extend the reading range between a contactless type information medium (semiconductor integrated circuit) and a reader/writer, which exchanges data in contactless communications with the contactless type information medium, and to enable a stable data exchange even if the power supply voltage is lowered when data is returned from the contactless type information medium to the reader/writer.

#### BRIEF DESCRIPTION OF THE DRAWINGS

[0029] [FIG. 1] FIG. 1 is a schematic diagram of a contactless IC card system.

[FIG. 2] FIG. 2 is a block diagram showing a configuration of a contactless IC card LSI according to an embodiment of the present invention.

[FIG. 3] FIG. 3 is a block diagram showing a configuration of a modulator circuit and a rectifier circuit according to an embodiment of the present invention.

[FIG. 4] FIG. 4 shows the relationship between the magnetic field intensity and the modulation factor.

[FIG. 5] FIG. 5 is a waveform diagram showing the relationship between a



return signal TXDATA, the voltage between coil terminals, the power supply voltage, the reset detection lower limit signal, etc.

[FIG. 6] FIG. 6 is a block diagram showing a configuration of a reset generating circuit according to an embodiment of the present invention

5 [FIG. 7] FIG. 7 is a waveform diagram showing the timing for switching a switch signal SW, and variations in the power supply voltage.

[FIG. 8] FIG. 8 is a waveform diagram showing the relationship between the return signal TXDATA, the reset detection voltage, etc., according to a variation of an embodiment of the present invention.

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#### DESCRIPTION OF REFERENCE NUMERALS

	[0030]	100	Analog circuit section
		110	Rectifier circuit
		111	Diode
15		112	Diode
		120	Power supply circuit
		130	Clock generating circuit
20		140	Demodulator circuit
		150	Modulator circuit
		151	Modulation factor adjusting resistor
		152	Modulation transistor
		160	Reset generating circuit
25		161	Inverter
		162	Reset detection lower limit voltage setting transistor
		163-165	Resistor
		166	Reference voltage generating circuit

	167	Comparator
	200	Logic circuit section
	300	Non-volatile memory circuit section
	410	Coil terminal
5	420	Coil terminal
	1000	Contactless IC card
	1100	Contactless IC card LSI
	1200	Antenna coil
	1300	Tuning capacitor
10	2000	Reader/writer
	2100	Antenna coil
	3000	Host device

#### BEST MODE FOR CARRYING OUT THE INVENTION

15 [0031] An embodiment of the present invention will now be described with reference to the drawings.

[0032] EMBODIMENT 1

#### Configuration Of Contactless IC Card System

FIG. 1 is a block diagram showing the outline of the configuration of a  
 20 contactless type information system (contactless IC card system) according to Embodiment 1 of the present invention. The contactless IC card system includes a contactless IC card 1000 and a reader/writer 2000. The reader/writer 2000 is connected to a host device 3000, which performs predetermined data processes, for communication with the host device 3000.

25 [0033] In the contactless IC card system having such a configuration, when the contactless IC card 1000 is brought close to the reader/writer 2000, the power supply

voltage is supplied via electromagnetic waves, and data can be exchanged therebetween by using electromagnetic waves even in a non-contact state. The data exchange is performed through a protocol in which the reader/writer **2000** transmits data to the contactless IC card **1000** and then the contactless IC card **1000** returns data to the reader/writer **2000**. As a result of the data exchange, the reader/writer **2000** can obtain data, such as personal information, stored in the memory of the contactless IC card **1000**. If the reader/writer **2000** communicates with the host device **3000** so as to transfer the data obtained by the reader/writer **2000** to the host device **3000**, data stored in the contactless IC card **1000** can be used for a wide variety of purposes.

10 [0034] Configuration Of Contactless IC Card **1000**

The contactless IC card **1000** includes a contactless IC card LSI **1100**, an antenna coil **1200** and a tuning capacitor **1300**, as shown in FIG. 2, and receives electromagnetic waves output from an antenna coil **2100** of the reader/writer **2000** at the antenna coil **1200**, whereby the power supply voltage is supplied to the contactless IC card LSI **1100** via the received electromagnetic waves.

[0035] The contactless IC card LSI **1100** includes an analog circuit section **100**, a logic circuit section **200**, a non-volatile memory circuit section **300** for storing data therein, and coil terminals **410** and **420**, as shown in FIG. 2.

20 [0036] The antenna coil **1200** is connected to the coil terminals **410** and **420** of the contactless IC card LSI **1100**, and the tuning capacitor **1300** is connected to the antenna coil **1200**. Therefore, when the antenna coil **1200** receives electromagnetic waves from the reader/writer **2000**, an alternating-current voltage is generated between the coil terminal **410** and the coil terminal **420**, and the generated alternating-current voltage is input to the analog circuit section **100**.

25 [0037] Configuration Of Analog Circuit Section **100**

The analog circuit section **100** includes a rectifier circuit **110**, a power supply

circuit **120**, a clock generating circuit **130**, a demodulator circuit **140**, a modulator circuit **150**, and a reset generating circuit **160**, as shown in FIG. 2.

[0038] As shown in FIG. 3, the rectifier circuit **110** is a voltage doubler rectifier including a diode **111** and a diode **112**, which rectifies the alternating-current voltage generated between the coil terminals **410** and **420** into a direct-current voltage and stabilizes the voltage so as to output a power supply voltage Vdd. A voltage doubler rectifier is characteristic in that the value of the rectified voltage is higher than that of other types of rectifier circuits.

[0039] The rectifier circuit **110** also outputs the rectified signal (received data signal) to the demodulator circuit **140**.

[0040] The power supply circuit **120** sends the power supply voltage Vdd, which has been rectified by the rectifier circuit **110**, to the entire contactless IC card LSI **1100**. This enables the entire contactless IC card LSI **1100** to operate.

[0041] The clock generating circuit **130** outputs a clock signal CLK, which is produced by receiving the alternating-current voltage generated between the opposite ends of the antenna coil **1200**, to the logic circuit section **200**.

[0042] The demodulator circuit **140** demodulates the received data signal, and outputs the demodulated signal (demodulated signal RXDATA) to the logic circuit section **200**.

[0043] Configuration Of Modulator Circuit **150**

The modulator circuit **150** is a load modulation type modulator circuit, including a modulation factor adjusting resistor **151** and a modulation transistor **152**, as shown in FIG. 3, and demodulates a return signal TXDATA from the logic circuit section **200** to output the demodulated signal to the coil terminals **410** and **420**. The alternating-current voltage generated between the opposite ends of the antenna coil **1200** (the voltage between the coil terminals **410** and **420**) is varied by the modulation transistor **152** and the modulation factor adjusting resistor **151** of the modulator circuit **150**. Thus, the load of

the contactless IC card 1000 is varied.

[0044] The resistance value of the modulation factor adjusting resistor 151 used in the modulator circuit 150 is determined as follows.

[0045] Typically, the characteristics of the modulator circuit 150 are represented by the modulation factor, which indicates the data communications capability between the contactless IC card 1000 and the reader/writer 2000, as shown in FIG. 4. The modulation factor needs to satisfy the standard specified in the international standard ISO/IEC 14443-2 regarding contactless IC cards. In order to satisfy the standard, the modulation factor of the modulator circuit 150 needs to be present within the region above the solid line (1)  $(30/H^{1.2} \text{ [mVp]})$  in FIG. 4. Typically, the weaker the magnetic field intensity is, the smaller the voltage generated in the contactless IC card 1000 is. Therefore, it is necessary to increase the modulation factor in order to enable data communications between the contactless IC card 1000 and the reader/writer 2000.

[0046] As indicated by the solid line (2) and the solid line (3) in FIG. 4, the magnitude of the modulation factor is not substantially dependent on the magnetic field intensity, i.e., the voltage generated between the coil terminals 410 and 420, but is dependent on the resistance value of the modulation factor adjusting resistor 151 of the modulator circuit 150. Therefore, by setting the resistance value of the modulation factor adjusting resistor 151 to be smaller than a predetermined value, it is possible to increase the modulation factor to such an extent that it is possible to sufficiently enable data communications between the contactless IC card 1000 and the reader/writer 2000, so as to realize stable data communications, even when the magnetic field intensity is low.

[0047] Configuration Of Reset Generating Circuit 160

The reset generating circuit 160 compares the threshold value (the reset detection lower limit voltage  $V_{reset}$ ) that is switched from one to another by a switch signal SW (a signal that, when being at the High level, indicates a data-returning period

where data is being returned from the contactless IC card **1000** to the reader/writer **2000**) input from the logic circuit section **200** with the power supply voltage  $V_{dd}$ . If the power supply voltage  $V_{dd}$  is lower than the reset detection lower limit voltage  $V_{reset}$ , the reset generating circuit **160** outputs, to the logic circuit section **200**, the reset signal RESET for resetting the logic circuit section **200**, being brought from the Low level (the L level) to the High level (the H level). When the power supply voltage  $V_{dd}$  reaches the reset detection lower limit voltage  $V_{reset}$ , the reset generating circuit **160** brings the reset signal RESET from the H level to the L level. The value ( $V_{re1}$ ), which is used as the reset detection lower limit voltage  $V_{reset}$  during the period in which the switch signal SW is at the L level (i.e., other than when data is being returned), is set to such a voltage level that the entire contactless IC card LSI **1100** will not undergo an erroneous operation. The value ( $V_{re2}$ ), which is used during the period in which the switch signal SW is at the H level (i.e., the data-returning period), is set to such a voltage level that at least the logic circuit section **200** will not undergo an erroneous operation, the voltage level being lower than the power supply voltage  $V_{dd}$  (the voltage between the coil terminals **410** and **420**) being lowered due to the return of data (the non-volatile memory circuit section **300** may possibly undergo an erroneous operation at this voltage).

[0048] The reset detection lower limit voltage  $V_{reset}$  is switched from one to another depending on whether the current period is a data-returning period, for the following reason.

[0049] For example, in the period in which data is being returned from the contactless IC card **1000** to the reader/writer **2000** (when the return signal TXDATA output from the logic circuit section **200** is at the L level), the modulation transistor **152** of the modulator circuit **150** is ON, and the voltage between the coil terminals **410** and **420** decreases. However, when the voltage between the coil terminals **410** and **420** is sufficiently high (e.g., when the contactless IC card **1000** and the reader/writer **2000** are close to each other)

or when the resistance value of the modulation factor adjusting resistor **151** of the modulator circuit **150** is sufficiently large, the supplied power is sufficiently high even if the modulation transistor **152** is ON, whereby there is little decrease in the voltage between the coil terminals **410** and **420**. For example, during the period in which the return signal TXDATA is at the L level, if the resistance value of the modulation factor adjusting resistor **151** is large, the power supply voltage Vdd decreases from Vdd0 (Vdd0=5.0 V) to Vdd1 (Vdd1=4.5 [V]) as indicated by the straight line (1) in FIG. 5. Therefore, there is little decrease in the power supply voltage Vdd, and if the reset detection lower limit voltage Vreset is set to be lower than Vdd1, the reset signal RESET will not be generated, thereby allowing for data communications between the contactless IC card **1000** and the reader/writer **2000**.

[0050] As the voltage between the coil terminals **410** and **420** is lower (e.g., as the contactless IC card **1000** and the reader/writer **2000** are more spaced apart from each other) or as the resistance value of the modulation factor adjusting resistor **151** is smaller, it is more likely that the power supply voltage Vdd decreases when the modulation transistor **152** of the load modulation type modulator circuit **150** is turned ON. For example, if the resistance value of the modulation factor adjusting resistor **151** is smaller than a predetermined value, the power supply voltage Vdd decreases from Vdd0 to Vdd2 (Vdd2=3.0 [V]) as indicated by the straight line (2) in FIG. 5. Then, when the reset generating circuit **160** detects the decrease in the power supply voltage Vdd and outputs the reset signal RESET to the contactless IC card LSI **1100**, the entire contactless IC card LSI **1100** stops operating. When the operation of the contactless IC card LSI **1100** stops, it is no longer possible to perform data communications between the contactless IC card **1000** and the reader/writer **2000**.

[0051] Therefore, if the resistance value of the modulation factor adjusting resistor **151** is set to be small, there will be a substantial decrease in the power supply voltage Vdd

when the return signal TXDATA sent from the logic circuit section **200** to the modulator circuit **150** is at the L level (where data is returned from the contactless IC card **1000** to the reader/writer **2000**), where the magnetic field intensity is low, whereby it may no longer be possible to perform data communications between the contactless IC card **1000** and the reader/writer **2000** if the reset generating circuit **160** outputs the reset signal RESET to the logic circuit section **200**.

[0052] In summary, when the resistance value of the modulation factor adjusting resistor **151** is smaller, the modulation factor is higher, but the power supply voltage is decreased by a larger amount when data is returned from the contactless IC card **1000** to the reader/writer **2000**. When the resistance value of the modulation factor adjusting resistor **151** is larger, the power supply voltage is decreased by a smaller amount when data is returned from the contactless IC card **1000** to the reader/writer **2000**, but the modulation factor is smaller where the magnetic field intensity is low.

[0053] In order to set the value of the modulation factor adjusting resistor **151** of the modulator circuit **150** to a value such that a sufficient modulation factor can be obtained, so that the reset signal RESET will not be brought to the H level, thus maintaining the state where it is possible to perform data communications between the contactless IC card **1000** and the reader/writer **2000** even if the power supply voltage Vdd is decreased by a large amount, the reset detection lower limit voltage Vreset of the reset generating circuit **160** needs to be decreased below the power supply voltage (Vdd2) of the data-returning period as described above during the period in which data is being returned from the contactless IC card **1000** to the reader/writer **2000**.

[0054] Specific Configuration Of Reset Generating Circuit **160**

Specifically, the reset generating circuit **160** includes an inverter **161**, a reset detection lower limit voltage setting transistor **162**, resistors **163** to **165**, a reference voltage generating circuit **166**, and a comparator **167**, as shown in FIG. 6.



[0055] The inverter **161** inverts the level of the switch signal SW.

[0056] The reset detection lower limit voltage setting transistor **162** receives, at the gate terminal thereof, the switch signal SW via the inverter **161**, and controls the number of resistors (the resistors **163** to **165**) connected together in series for decreasing the power supply voltage Vdd through voltage division. Thus, where the switch signal SW is at the H level, the voltage at the node between the resistor **163** and the resistor **164** is the power supply voltage Vdd.

[0057] The resistors **163** to **165** have the resistance values of R1, R2 and R3, respectively, and are provided so as to decrease the power supply voltage Vdd through voltage division.

[0058] The reference voltage generating circuit **166** is a circuit for generating a predetermined voltage and is, for example, a bandgap reference voltage generating circuit, or the like. An example where the output voltage Vref of the reference voltage generating circuit **166** is about 1.2 V will be described below.

[0059] The comparator **167** compares the voltage VR at the node between the resistor **164** and the resistor **165** with the output voltage Vref of the reference voltage generating circuit **166**.

[0060] With such a configuration, when the switch signal SW is sent from the logic circuit section **200**, the reset generating circuit **160** can increase the voltage VR at the node between the resistor **164** and the resistor **165** to a predetermined voltage to thereby decrease the reset detection lower limit voltage Vreset to a predetermined voltage.

[0061] The voltage VR can very easily be set by setting the resistance values of the resistors **163** to **165** to predetermined values. For example, if the reset detection lower limit voltage Vreset (=Vre1) where the switch signal SW is at the L level is 4.5 [V], the reset detection lower limit voltage Vreset (=Vre2) where the switch signal SW is at the H level 3.0 [V], the output voltage Vref of the reference voltage generating circuit **166** is 1.2

V, and  $R1+R2+R3=1$  [M $\Omega$ ], the resistance values R1, R2 and R3 of the resistors 163 to 165 can be obtained by solving the set of simultaneous equations of Expressions 1 to 3 below.

$$R1+R2+R3=1000 \text{ [k}\Omega\text{]} \quad \text{Exp. 1}$$

$$4.5/(R1+R2+R3)=1.2/R3 \quad \text{Exp. 2}$$

5 (the value of the current flowing through the resistor of the reset generating circuit 160 when the switch signal SW is at the L level)

$$3.0/(R2+R3)=1.2/R3 \quad \text{Exp. 3}$$

(the value of the current flowing through the resistor of the reset generating circuit 160 when the switch signal SW is at the H level)

10 Based on Expressions 1 to 3 above, the resistance values of the resistors 163 to 165 are as follows:  $R1=333.33$  [k $\Omega$ ],  $R2=400.00$  [k $\Omega$ ] and  $R3=266.67$  [k $\Omega$ ].

[0062] Therefore, where the switch signal SW is at the L level, the resistor dividing the power supply voltage Vdd is a series of resistors 163, 164 and 165, whereby the reset detection lower limit voltage Vreset is  $Vre1=4.5$  [V]. When the voltage VR at the node  
15 between the resistor 164 and the resistor 165 is lower than 1.2V (i.e., when the power supply voltage Vdd is lower than  $Vre1=4.5$  [V]), the reset signal RESET transitions from the L level to the H level.

[0063] When the switch signal SW is at the H level, the resistor dividing the power supply voltage Vdd is a series of resistors 164 and 165, whereby the reset detection lower  
20 limit voltage Vreset is  $Vre2=3.0$  [V]. When the voltage VR is lower than 1.2 V (when the power supply voltage Vdd is lower than  $Vre2=3.0$  [V]), the reset signal RESET transitions from the L level to the H level.

[0064] In order to set the reset detection lower limit voltage Vreset to be  $Vre1=4.5$  [V] or  $Vre2=3.0$  [V], the resistance values of the resistors 163 to 165 can be set to  $R1=333.33$   
25 [k $\Omega$ ],  $R2=400.00$  [k $\Omega$ ] and  $R3=266.67$  [k $\Omega$ ], respectively, with a circuit configuration as shown in FIG. 6.

[0065] Thus, in the reset generating circuit **160**, a plurality of resistors are connected together in series, and the number of resistors that decrease the power supply voltage  $V_{dd}$  is controlled by the reset detection lower limit voltage setting transistor **162** based on the state of the switch signal SW. Therefore, the two reset detection lower limit voltages  
5 Vre1 and Vre2 can be switched from one to another with a simple circuit configuration without increasing the circuit scale.

[0066] Configuration Of Logic Circuit Section **200**

The logic circuit section **200** outputs the switch signal SW to the reset generating circuit **160** in order to switch the reset detection lower limit voltage Vreset from  
10 one to another when data is returned from the contactless IC card **1000** to the reader/writer **2000**. Specifically, the logic circuit section **200** outputs the switch signal SW being at the H level in the data-returning period, and outputs the switch signal SW being at the L level in periods other than the data-returning period. The switch signal SW is brought to the H level simultaneously with the output of data to the modulator circuit **150**. Thus, before  
15 the power supply voltage decreases below the reset detection lower limit voltage, the reset detection lower limit voltage can be switched to be low.

[0067] When the switch signal SW is brought back from the H level to the L level, the switch signal SW is brought to the L level after the return of data is completed as indicated by the solid line (3) in FIG. 7.

[0068] For example, FIG. 7 is an enlarged view showing signal waveforms observed when data is exchanged between the contactless IC card **1000** and the reader/writer **2000**. In this example, during the period in which the return signal TXDATA is at the L level, the voltage between the coil terminals **410** and **420** is decreased by the modulator circuit **150** to  $V_{dd2}$ . After the return of data is completed, the return signal TXDATA is brought  
20 from the L level to the H level, and the voltage between the coil terminals **410** and **420** increases toward the  $V_{dd0}$  level, and the power supply voltage  $V_{dd}$  increases from  $V_{dd2}$   
25

toward Vdd0 along with the voltage increase.

[0069] However, the rate at which the power supply voltage Vdd increases varies depending on capacitors parasitically included within the contactless IC card LSI 1100 or capacitors added thereto. Specifically, when the internal capacitance of the contactless IC  
5 card LSI 1100 is larger, the power supply voltage Vdd starts increasing slowly when the return of data from the contactless IC card 1000 to the reader/writer 2000 is completed, as indicated by the solid line (2) in FIG. 7.

[0070] Therefore, if there is a small time difference between when the switch signal SW sent from the logic circuit section 200 to the reset generating circuit 160 transitions  
10 from the H level to the L level and when the return signal TXDATA sent from the logic circuit section 200 to the modulator circuit 150 transitions to the H level, the reset detection lower limit voltage Vreset of the reset generating circuit 160 rises to Vrel, as indicated by the dotted line (5) in FIG. 7, before the power supply voltage Vdd sufficiently returns to the voltage level Vdd0. As a result, the reset generating circuit 160 outputs the  
15 reset signal RESET being at the H level, whereby it is no longer possible to perform data communications between the contactless IC card 1000 and the reader/writer 2000. Thus, the logic circuit section 200 needs to delay the fall of the switch signal SW as described above.

[0071] However, if the fall of the switch signal SW is delayed excessively, the  
20 operation of the non-volatile memory circuit section 300 starts while the contactless IC card LSI 1100 performs the internal operation. Thus, the logic circuit section 200 can delay the fall of the switch signal SW by a period longer than the period in which the return signal TXDATA is at the L level with respect to the rise of the return signal TXDATA sent to the modulator circuit 150 as shown in FIG. 7. Specifically, the  
25 modulation frequency is 848 kHz in the international standard "ISO/IEC 14443 Type B" for contactless IC cards, and therefore the fall of the switch signal SW can be delayed by a

period greater than or equal to  $1.18 [\mu\text{s}/2]$ , i.e.,  $590 [\text{ns}]$ . Specifically, the logic circuit section **200** is configured so that the switch signal SW transitions with timings as described above by using the clock signal CLK output by the clock generating circuit **130**.

[0072] The logic circuit section **200** outputs a control signal Ctrl and an address signal  
5 Add to the non-volatile memory circuit section **300** so as to read out or write a data signal DATA from or to the specified address.

[0073] The logic circuit section **200** performs a reset operation upon transition of the reset signal RESET from the L level to the H level. When the reset signal RESET is at the H level, the logic circuit section **200** does not output the control signal Ctrl to the non-  
10 volatile memory circuit section **300**. Thus, the logic circuit section **200** cannot access the non-volatile memory circuit section **300**. When the reset signal RESET is at the L level, the logic circuit section **200** outputs the control signal Ctrl to the non-volatile memory circuit section **300**. The instance of the transition of the reset signal RESET from the H level to the L level is when the access to the non-volatile memory circuit section **300** is  
15 allowed. When the access to the non-volatile memory circuit section **300** is being allowed, the logic circuit section **200** can read or write data stored in the non-volatile memory circuit section **300** as described above.

[0074] This not only allows an external device such as the reader/writer **2000** to transmit data to the contactless IC card **1000**, but also allows data stored in the non-volatile  
20 memory circuit section **300** to be returned from the contactless IC card **1000** to the reader/writer **2000**.

[0075] The logic circuit section **200** buffers data read out from the non-volatile memory circuit section **300** (data to be returned). When data is returned from the contactless IC card **1000** to the reader/writer **2000**, the return signal TXDATA, output to  
25 the modulator circuit **150**, is brought from the H level to the L level to thereby output the buffered data.

[0076] When the read-out data is returned, buffered data is used without activating the non-volatile memory circuit section **300** for the following reason.

[0077] For example, where no data at all is being exchanged between the contactless IC card **1000** and the reader/writer **2000** and the reset detection lower limit voltage  $V_{reset}$  of the reset generating circuit **160** is lowered to  $V_{re2}$  (3.0 [V] or less), if the logic circuit section **200** outputs the control signal  $Ctrl$  to the non-volatile memory circuit section **300**, the non-volatile memory circuit section **300** is activated. The logic circuit section **200** typically includes only logic gates, and operates normally even if the power supply voltage  $V_{dd}$  drops to about 3.0 [V].

[0078] However, the non-volatile memory circuit section **300** includes not only logic gates but also memory cells, etc. Therefore, if the non-volatile memory circuit section **300** is activated with the power supply voltage  $V_{dd}$  having dropped to about 3.0 [V], the write time to memory cells of the non-volatile memory circuit section **300**, etc., will not be as prescribed, whereby a normal operation is no longer be guaranteed. Thus, the design needs to be such that the non-volatile memory circuit section **300** is not activated when the power supply voltage  $V_{dd}$  drops to about 3.0 [V].

[0079] Therefore, in the logic circuit section **200**, when data is returned from the contactless IC card **1000** to the reader/writer **2000** as described above, the control signal  $Ctrl$  is not output to the non-volatile memory circuit section **300** so as not to activate the non-volatile memory circuit section **300**, whereby only the logic circuit section **200** operates to output buffered data to the modulator circuit **150**.

[0080] Operation Of Contactless IC Card System

In the contactless IC card system having such a configuration, data is exchanged as follows. When the contactless IC card **1000** is brought within a predetermined distance from the reader/writer **2000**, an alternating-current voltage is generated through the antenna coil **1200** and rectified through the rectifier circuit **110**, after

which it is output from the power supply circuit **120** as the power supply voltage  $V_{dd}$  so as to be supplied to the entire contactless IC card LSI **1100**. Data transmitted from the reader/writer **2000** is received by the antenna coil **1200**, input to the demodulator circuit **140** via the rectifier circuit **110**, and then demodulated by the demodulator circuit **140**.

5 [0081] Data is returned from the contactless IC card **1000** to the reader/writer **2000** as follows. First, the logic circuit section **200** outputs the control signal Ctrl and the address signal Add to the non-volatile memory circuit section **300**, thereby reading out data to be returned from the non-volatile memory circuit section **300** and then storing the data in the buffer.

10 [0082] The logic circuit section **200** brings the switch signal SW from the L level to the H level, and lowers the reset detection lower limit voltage Vreset of the reset generating circuit **160** from Vre1 (=4.5 [V]) to Vre2 (=3.0 [V]).

[0083] At this time, the logic circuit section **200** brings the control signal Ctrl to the L level so that the non-volatile memory circuit section **300** will not be activated. Then, the  
15 logic circuit section **200** outputs the return signal TXDATA, being at the L level, to the modulator circuit **150**, whereby the modulation transistor **152** of the modulator circuit **150** is turned ON.

[0084] In the present embodiment, during the period in which the return signal TXDATA is at the L level, the coil terminals **410** and **420** are connected together via the  
20 modulation factor adjusting resistor **151** and the voltage between the coil terminals **410** and **420** is therefore lowered, but the reset detection lower limit voltage Vreset of the reset generating circuit **160** is switched by the non-volatile memory circuit section **300** to Vre2. Therefore, even if the voltage between the coil terminals **410** and **420** is lowered, the logic circuit section **200** is not reset and data (the return signal TXDATA) is returned to the  
25 reader/writer **2000** via the modulator circuit **150**.

[0085] As described above, in the present embodiment, data to be returned is held in

the logic circuit that can operate at a lower voltage than the non-volatile memory circuit section, and the reset detection lower limit voltage is lowered during the data-returning period. Therefore, it is possible to sufficiently increase the modulation factor to extend the reading range between the contactless IC card and the reader/writer, thus realizing a stable data exchange. Thus, the semiconductor integrated circuit of the present invention is useful in the application to contactless IC cards of the proximity type (reading range: 0 to 10 cm) expected to be widespread in the near future.

[0086] VARIATION OF EMBODIMENT 1

The contactless IC card LSI 1100 of Embodiment 1 may further include a high voltage-side reset generating circuit obtained by adding, to the reset generating circuit 160, an inverter for inverting the output of the comparator 167.

[0087] The switch signal SW is input from the logic circuit section 200 to the high voltage-side reset generating circuit, and the contactless IC card LSI 1100 is configured so as to output the reset signal RESET to the logic circuit section 200.

[0088] The high voltage-side reset generating circuit compares the power supply voltage Vdd with the threshold value (the reset detection upper limit voltage V'reset) that is switched from one to another by the switch signal SW input from the logic circuit section 200. If the power supply voltage Vdd exceeds the reset detection upper limit voltage V'reset, the reset signal RESET for resetting the logic circuit section 200 is brought from the L level to the H level and output to the logic circuit section 200. If the power supply voltage Vdd decreases below the reset detection upper limit voltage V'reset, the reset signal RESET is brought from the H level to the L level.

[0089] Where the power supply voltage Vdd decreases from Vdd0 to Vdd2 when data is returned from the contactless IC card 1000 to the reader/writer 2000 (during the period in which the return signal TXDATA sent from the logic circuit section 200 to the



modulator circuit 150 is at the L level), the value (Vre3) used as the reset detection upper limit voltage V'reset during the period in which the switch signal SW is at the L level (i.e., other than the data-returning period) is set to a voltage level such that  $V_{re3} > V_{dd0}$ . The value (Vre4) used during the period in which the switch signal SW is at the H level (i.e.,  
5 the data-returning period) is set to a voltage level such that  $V_{re4} > V_{dd2}$ .

[0090] The two different reset detection upper limit voltages Vre3 and Vre4 can be controlled by setting the values of the resistors 163 to 165 to predetermined values also in the high voltage-side reset generating circuit and by varying the number of resistors to be used for dividing the power supply voltage by the reset detection lower limit voltage  
10 setting transistor 162.

[0091] As Vre3 and Vre4 are thus controlled, the reset detection upper limit voltage varies as shown in FIG. 8 according to the switch signal SW and the return signal TXDATA.

[0092] For example, if a third person attempts, with malicious intent, to externally  
15 power the contactless IC card LSI 1100 of this variation to read out, or overwrite, signals inside the contactless IC card LSI 1100 and data stored in the non-volatile memory circuit section 300, the third person needs to externally supply a voltage that can be used in place of the power supply voltage Vdd.

[0093] Where a power supply voltage, in place of the power supply voltage Vdd, is  
20 externally supplied, the voltage needs to be always higher than the reset detection lower limit voltage Vreset and lower than the reset detection upper limit voltage V'reset so that the reset signal RESET will not be generated.

[0094] It is very difficult to have such an external power supply voltage always adjusted so that the reset signal RESET will not be generated. Thus, with the contactless  
25 IC card system of this variation, it is easy to substantially improve the security of the contactless IC card LSI 1100 without complicating the circuit configuration of the reset

generating circuit **160**.

[0095] With the reset generating circuit **160** described in the above embodiment, the reset signal RESET at the L level may always be output to the logic circuit section **200** when the switch signal SW is input, instead of determining the two different reset detection lower limit voltages Vre1 and Vre2 as described above. Even with such a configuration, it is possible to maintain data communications between the contactless IC card **1000** and the reader/writer **2000**.

[0096] The output voltage of the reference voltage generating circuit **166** is merely an example, and the present invention can be used with a circuit that outputs a voltage different from the output voltage as long as the resistors **163** to **165** are set to predetermined values.

[0097] While a voltage doubler rectifier is used as the rectifier circuit **110** in the above embodiment, the present invention may use a rectifier circuit that rectifies radio waves by means of a full-wave rectifier circuit or a half-wave rectifier circuit.

[0098] While a circuit that modulates the voltage between the coil terminals **410** and **420** is used as the modulator circuit **150** of the above embodiment, it may alternatively be a modulator circuit that modulates the power supply voltage Vdd.

[0099] The relationship between each level of each signal and the representation thereof in the above embodiment is merely an example, and the present invention is not limited thereto.

#### INDUSTRIAL APPLICABILITY

[0100] The semiconductor integrated circuit of the present invention and the contactless type information system including the same are advantageous in that it is possible to extend the reading range between the contactless type information medium (semiconductor integrated circuit) and the reader/writer, which exchanges data in

contactless communications with the contactless type information medium, and in that data can be exchanged stably even if the power supply voltage is lowered when data is returned from the contactless type information medium to the reader/writer. Thus, the present invention is useful as a semiconductor integrated circuit to which power is supplied via  
5 electromagnetic waves, and an information system (contactless type information system), etc., including a contactless type information medium, which includes the semiconductor integrated circuit.